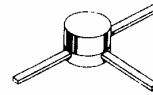


MMCM918HXV/HS (SINGLE)
MD918FHXV/HS (DUAL)
MD918AFHXV/HS (DUAL)
MQ918HXV/HS (QUAD)

CRYSTALONCS
 2605 Veterans Highway
 Suite 14
 Ronkonkoma, N.Y. 11779

Surface Mountable
Small-Signal Transistor
 30 Volt, 50 Milliampere Bipolar NPN Silicon

MAXIMUM RATINGS				
Rating	Symbol	Value		Unit
Collector-Emitter Voltage	V _{CEO}	15		V _{dc}
Collector-Base Voltage	V _{CB0}	30		V _{dc}
Emitter-Base Voltage	V _{EB0}	3.0		V _{dc}
Collector Current — Continuous	I _C	50		mA _{dc}
		One Die	All Die	
Device Dissipation @ T _A = 25 °C	P _T			mW
MMCM918		200	—	
MD918F.AF		350	400	
MQ918		350	400	
Derate above 25 °C				mW/°C
MMCM918		1.14	—	
MD918F.AF		2.0	2.28	
MQ918		2.0	2.28	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to +200		°C



CASE 176C-01



CASE 607-04



CASE 610A-04

MMCM918HXV/HS, MD918FH XV/HS, MD918AFHXV/HS, MQ918HXV/HS

ELECTRICAL CHARACTERISTICS (T _A = 25°C unless noted)				
Characteristic	Symbol	Min	Max	Unit
Collector-Emitter Breakdown Voltage (I _C = 3.0 mA _{dc} , I _B = 0)	V _{(BR)CEO}	15	—	V _{dc}
Collector-Base Breakdown Voltage (I _C = 1.0 mA _{dc} , I _E = 0)	V _{(BR)CBO}	30	—	V _{dc}
Emitter-Base Breakdown Voltage (I _E = 10 mA _{dc} , I _C = 0)	V _{(BR)EBO}	3.0	—	V _{dc}
Collector Cutoff Current (V _{CB} = 25 V _{dc} , I _E = 0) (V _{CB} = 25 V _{dc} , I _E = 0, T _A = 150°C)	I _{CBO}	— —	10 1.0	nA _{dc} μA _{dc}
Emitter Cutoff Current (V _{EB} = 2.5 V _{dc})	I _{EBO}	—	10	nA _{dc}
DC Current Gain (I _C = 500 μA _{dc} , V _{CE} = 10 V _{dc}) (I _C = 3.0 mA _{dc} , V _{CE} = 1.0 V _{dc}) (I _C = 10 mA _{dc} , V _{CE} = 10 V _{dc}) (I _C = 3.0 mA _{dc} , V _{CE} = 1.0 V _{dc} , T _A = -55°C)	h _{FE}	10 20 20 10	— 200 — —	—
Collector-Emitter Saturation Voltage (I _C = 10 mA _{dc} , I _B = 1.0 mA _{dc})	V _{CE(sat)}	—	0.4	V _{dc}
Base-Emitter Saturation Voltage (I _C = 10 mA _{dc} , I _B = 1.0 mA _{dc})	V _{BE(sat)}	—	1.0	V _{dc}
Output Capacitance (V _{CB} = 10 V _{dc} , I _E = 0, f = 0.1 to 1.0 MHz) (V _{CB} = 0 V _{dc} , I _E = 0, f = 0.1 to 1.0 MHz)	C _{obo}	— —	1.7 3.0	pF
Input Capacitance (V _{BE} = 0.5 V _{dc} , I _C = 0, f = 0.1 to 1.0 MHz)	C _{ibo}	—	2.0	pF
Transfer Current Ratio, Magnitude (I _C = 4.0 mA _{dc} , V _{CE} = 10 V _{dc} , f = 100 MHz)	h _{fe}	6.0	18	—
Power Gain (V _{CB} = 12 V _{dc} , I _C = 6.0 mA _{dc} , f = 200 MHz)	G _{pe}	15	—	dB
Power Output (V _{CB} = 15 V _{dc} , I _C = 8.0 mA _{dc} , f = 500 MHz)	P _o	30	—	mW
Efficiency (V _{CB} = 15 V _{dc} , I _C = 8.0 mA _{dc} , f = 500 MHz)	η	25	—	%
Noise Figure (I _C = 1.0 mA _{dc} , V _{CE} = 6.0 V _{dc} , f = 60 MHz, R _S = 400)	NF	—	6.0	dB
MATCHING CHARACTERISTICS (MD918AF only)				
DC Current Gain Ratio (I _C = 1.0 mA _{dc} , V _{CE} = 5.0 V _{dc})	h _{FE1} :h _{FE2}	0.9	1.0	—
Base-Emitter Voltage Differential (I _C = 1.0 mA _{dc} , V _{CE} = 5.0 V _{dc})	V _{BE1} - V _{BE2}	—	5.0	mV _{dc}
Base-Emitter Voltage Differential Gradient (I _C = 1.0 mA _{dc} , V _{CE} = 5.0 V _{dc} , T _A = -55 to +125°C)	$\frac{\Delta(V_{BE1} - V_{BE2})}{\Delta T_A}$	—	10	μV _{dc} C

ASSURANCE TESTING (Pre/Post Burn-In)				
Burn-In Test Conditions: T _A = 25 ±3°C, V _{CB} = 10 V _{dc} , P _T = Rated Power				
Characteristics Tested	Symbol	Min	Max	Unit
Collector Cutoff Current (V _{CB} = 25 V _{dc})	I _{CBO}	—	10	nA _{dc}
DC Current Gain (I _C = 3.0 mA _{dc} , V _{CE} = 1.0 V _{dc})	h _{FE}	20	200	—

Delta from Pre-Burn-In Measured Values			
Delta Collector Cutoff Current	ΔI _{CBO}	100 or 5.0 whichever is greater	% Initial nA _{dc}
Delta DC Current Gain	Δh _{FE}	±20	% Initial